

## Terminology

**Transducer** – A device that converts a nonelectrical quantity into an electrical signal and vice versa

- **Sensor** – A device that converts a nonelectrical quantity into an electrical signal
  - An input transducer
  - Examples: pressure sensor, accelerometer
- **Actuator** – A device that converts an electrical signal into a nonelectrical quantity
  - An output transducer
  - Examples: motor, light bulb, electric heater

**Measurand** – the quantity being measured by the sensor (such as pressure or temperature)

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## Size

**Macro** – 2mm and larger (us: 6' = 1.8288m) – our world

**Meso** – 2mm down to 500 $\mu$ m (small fire ant is 2mm long) – her world

**Micro** – 500 $\mu$ m down to 0.5 $\mu$ m (paramecium is 100 $\mu$ m to 300 $\mu$ m long, human red blood cell has a 6 $\mu$ m to 8 $\mu$ m diameter)

**Nano** – 0.5 $\mu$ m down to 1nm (spherical influenza virus: 50nm to 120nm diameter with 10nm to 14nm spikes on surface)

Human Hair: ~100 $\mu$ m diameter

Modern Transistor: <100nm dimensions (TSMC has a 5 nm process)

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**MEMS:** acronym for “Microelectromechanical Systems”

Definition: Any device or system partially or fully manufactured using microfabrication techniques

**Microsensor:** a sensor with at least one sub-mm physical dimension

### MEMS Characteristics

- (1) Typically based around a silicon substrate
- (2) Typically use batch fabrication processing borrowed from microelectronics fabrication technology

Batch Fabrication: many devices fabricated in parallel

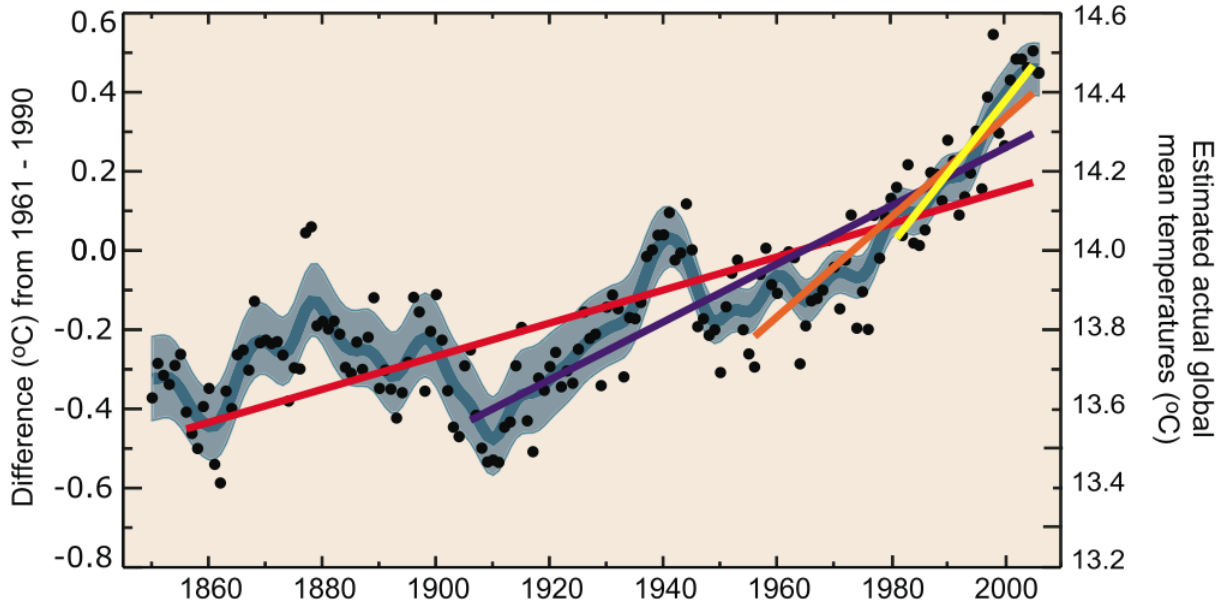
■ Reduces Cost per Device

- (3) Sometimes compatible with microelectronics fabrication
- (4) But often not compatible with microelectronics fabrication

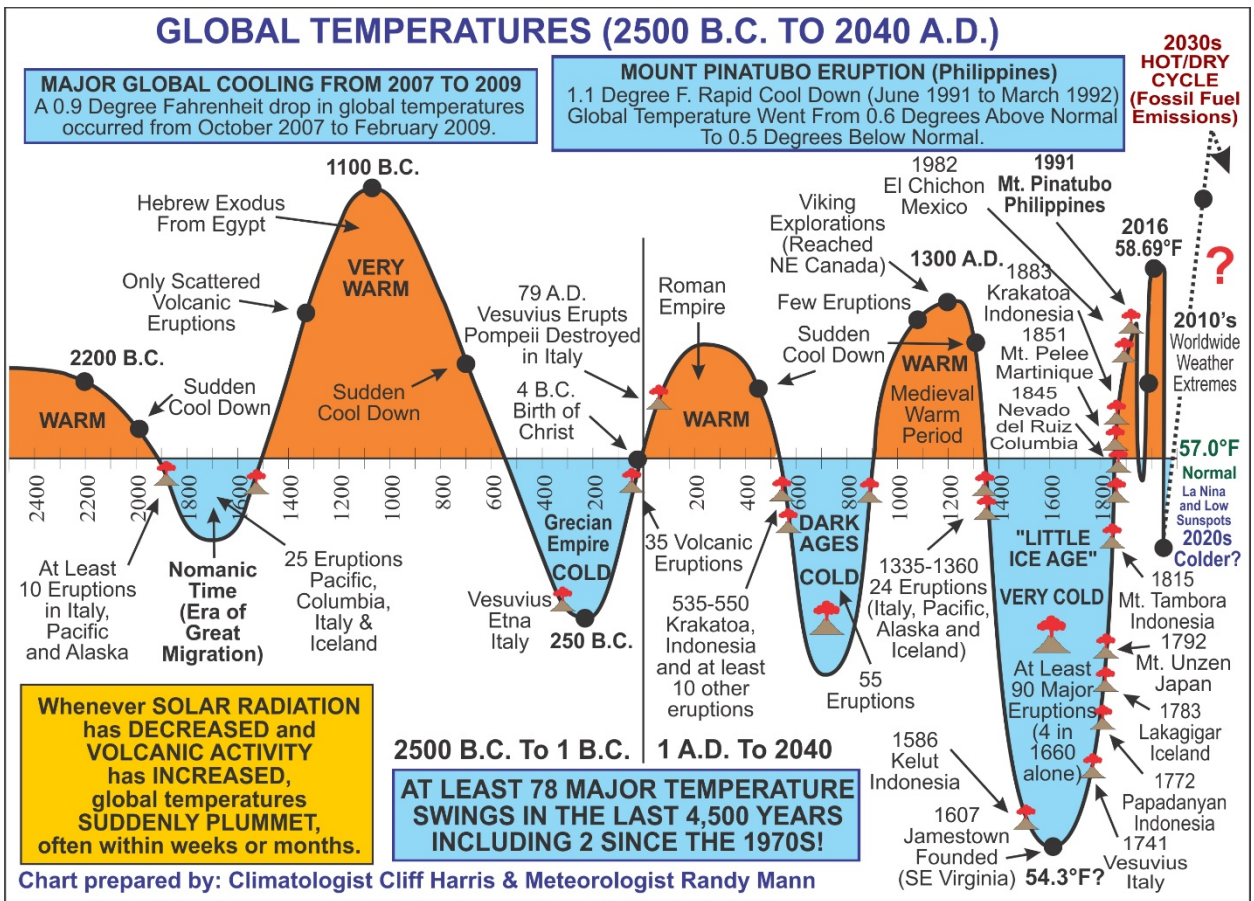
### Sensor and Sensing Characteristics

- (1) Accuracy – how correct the sensor readings are
- (2) Precision – the resolution of the sensor
- (3) Range – defines the minimum and maximum measurand levels that can be sensed
- (4) Minimum sampling rate – must be at least twice the highest frequency present in the data to avoid aliasing
- (5) Minimum sample collection period – must be long enough to capture any trends present in the data (see example on next page)

### Global Mean Temperature

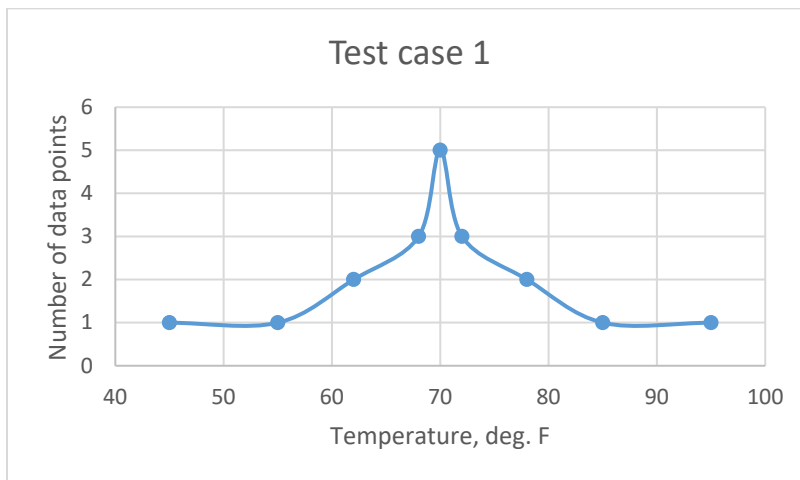


[https://wg1.ipcc.ch/publications/wg1-ar4/faq/wg1\\_faq-3.1.html](https://wg1.ipcc.ch/publications/wg1-ar4/faq/wg1_faq-3.1.html)



## Statistics of Sensor Data

- (1) Average (mean) – sum total of the values divided by the number of values of the data set
- (2) Median – the middle value of the data set. Same number of data points above and below the median.
- (3) Standard Deviation ( $\sigma$ ) – a measure of the amount of variation in a set of data values. 68.27% of the data set lies within  $\pm 1 \sigma$ . 95.4% within  $\pm 2 \sigma$ .

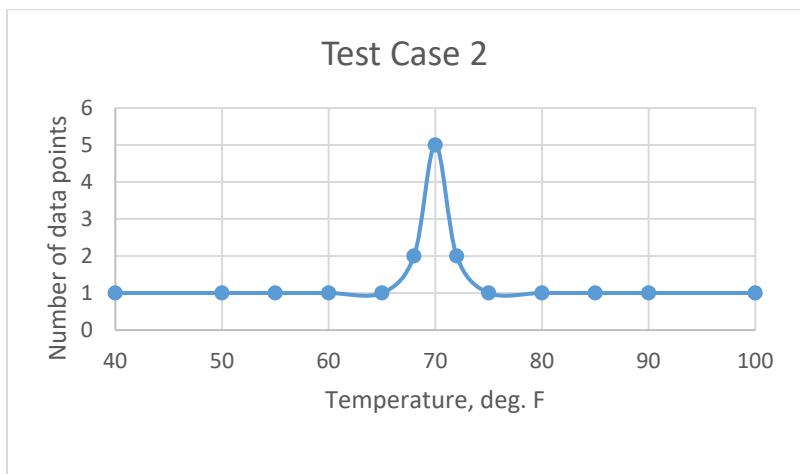


Symmetrical Distribution

Average = 70 F

Median = 70 F

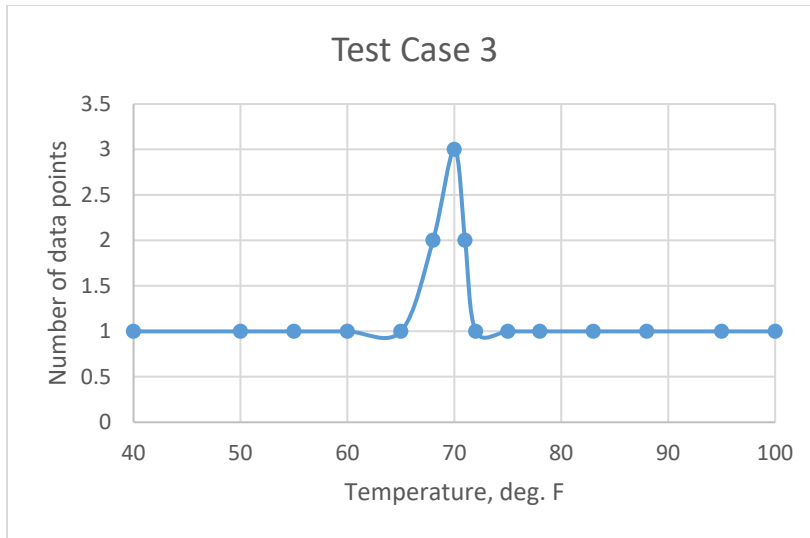
$\sigma = 10.2$  F



Average = 70 F

Median = 70 F

$\sigma = 13.2$  F



Skewed Distribution (most data points are below the average)

Average = 71 F

Median = 70 F

$\sigma = 14.1$  F

Note: in the case above, you are more likely to have data points below the average: this is then the “normal” case. But you wouldn’t know that from just comparing data to the average value...

## Scaling

The relative importance of physical quantities and forces varies with size

### **Dimensions:**

- Length:  $L \propto L$
- Surface area:  $A \propto L^2$
- Volume:  $V \propto L^3$

Therefore physical quantities proportional to volume decrease faster than quantities proportional to length as size is reduced

Example: a 50% reduction in x, y, z:  $L_{\text{new}} = 1/2 L_{\text{old}}$   
 $V_{\text{new}} = 1/8 V_{\text{old}}$

**Comparison of Macro and Micro Worlds:**

**Macro World**

- Inertial forces important
- Electromagnetic actuators more efficient
- Responds slowly to environmental temp change
- Fluidic forces less important

**Micro World**

- Inertial forces less important
- Electrostatic actuators more efficient
- Responds quickly to environmental temp change
- Fluidic forces important
- Friction, Van der Waals forces, capillary action important

**Examples of Microsensors:**

**Mechanical**

- flow rate
- proximity
- stress/strain
- pressure
- acceleration
- angular rate (gyroscope)

**Thermal**

- PTAT
- thermistor
- thermocouple

**Chemical**

- humidity
- gas detection
- moisture content

**Acoustic**

- microphone

**Radiation**

- micro-antenna
- photodetectors
- photovoltaic
- x-ray
- magnetic field
- electric field

**Biological**

- DNA analysis
- contagion (E. coli, anthrax, Covid...)

## **Introduction to Microfabrication**

Fabrication processes used to fabricate integrated circuits and most MEMS devices

For a more detailed study of microfabrication:

- (1) ELEC 5730/6730 Microelectronic Fabrication
- (2) ELEC 5820/6820 MEMS

**Micromachining**: A term used to describe the process of fabricating MEMS or micromachined devices

### **Silicon (Si)**

The base material for microfabrication: Substrate

Si is the most common substrate material

Si: hard, brittle semiconductor material

Single crystal Si is grown into ingots and sawn/polished to produce thin wafers – used as substrates

- (1) Example Si wafer: 100mm diameter and 500 $\mu$ m thick
  - (2) Diamond crystal structure, different crystalline planes: (100), (110), (111): with different properties
  - (3) Can be doped n- or p-type: can be high or low resistivity
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### **Other Materials in Si Based MEMS:**

- (1) **SiO<sub>2</sub>**: grown onto exposed Si through a process called oxidation  
Typically less than 1 μm thick
  - (2) **Polysilicon**: polycrystalline Si deposited onto a substrate  
Up to a few μm thick
  - (3) **Metallization**: deposited layers or “films” of metal (Al, Ti, Au, Cr...)  
Thin films: up to few μm thick  
Thick films: greater thicknesses (up to 100s of μm thick)
  - (4) **Non-metallic layers**:  
Silicon nitride (SiN)  
Various polymers  
Diamond coatings  
Epoxies
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### **Materials in Non-Si Based MEMS:**

- (1) SiC (silicon carbide)
  - (2) Diamond
  - (3) Glasses
  - (4) Ceramics
  - (5) Polymers / plastics
  - (6) PCB laminates
  - (7) Metals
  - (8) 3D printed materials
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### **2 Basic Processing Types:**

- (1) **Additive Process**: The deposition of a layer or volume of a material
- (2) **Subtractive Process**: The removal of some amount of a material



## **Basic Microfabrication Processing Terms**

**Patterning**: The process of transferring a designed pattern into a physical layer

**Photolithography**: A process of patterning a light-sensitive organic layer called photoresist (PR)

**Photolithography mask**: a transparent glass plate with an opaque pattern (plated Cr) on one side that the designer desires to transfer to the substrate or thin layer

### **Photolithography Process**

- (1) Clean wafer
- (2) Spin coat on a uniform layer of PR
- (3) “Soft bake” to dry the PR
- (4) Align the photolithography mask to the wafer and place it in contact with the PR layer – using a mask aligner
- (5) Expose it to UV light for a set time (only areas not covered by the Cr pattern are exposed)
- (6) Develop the PR in a liquid developer
  - Exposed PR removed – “positive PR”
  - Unexposed PR removed – “negative PR”
- (7) “Hard Bake” to harden the remaining PR

### **After Photolithography**

- (1) Affect the exposed layer beneath the PR
  - (2) Remove the remaining PR (solvents, O<sub>2</sub> plasma “ashing”)
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**Etching**: the selective removal of a material

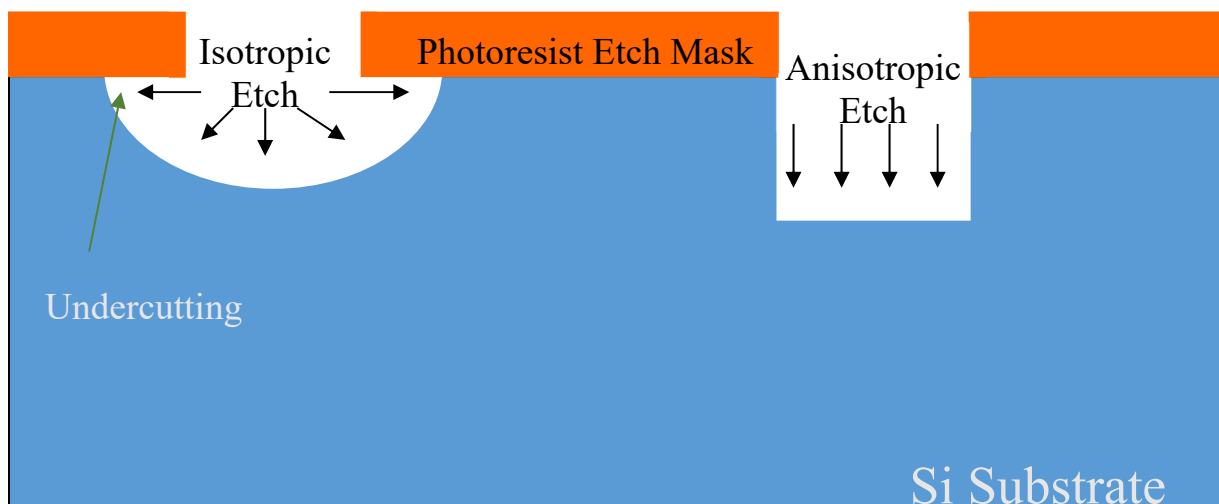
**Selectivity**: The properties of an etchant with regard to what it will and will not etch. Typically want a high selectivity.

**PR Etch Mask:** A patterned layer of PR used to only expose some areas for etching

**Isotropic Etch:** Equal etching effect in all directions

**Anisotropic Etch:** Unequal etching effect in different directions

**Undercutting:** Where the etch process undercuts the PR or other etch mask



There are no purely anisotropic etch processes.

**Aspect Ratio:** Ratio of depth to width of an etched feature.

Example: 10:1 - 10 $\mu$ m down, 1 $\mu$ m over